Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/609,111	DEVINE ET AL.	
Examiner	Art Unit	
My-Trang N. Ton	2816	

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Class	Subclass	Date	Examiner
326	81	11/16/2005	МТ
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327	309		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEAF (INCLUDING S	RCH NOTES SEARCH STRATEG	Y)
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East searches	11/16/2005	5 MT